

# FCC TEST REPORT

For

Wintop Electronics Co., Limited
Bluetooth Earphone

Model No.: BT-583

Prepared For : Wintop Electronics Co., Limited

Address : Unit 04 7/F, Bright Way Tower 33, Mong Kok RD, KL, Hong Kong

Prepared By : Shenzhen Anbotek Compliance Laboratory Limited

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Report Number : SZAWW180504013-01

Date of Test : May 05~15, 2018

Date of Report : May 15, 2018



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# TEST REPORT

Applicant : Wintop Electronics Co., Limited

Manufacturer : Shenzhen Wintop Electronics Co.,Ltd

Product Name : Bluetooth Earphone

Model No. : BT-583

Trade Mark : N/A

Rating(s) : Input: DC 5V, 1A (with DC 3.7V, 170 mAh Battery inside)

Test Standard(s) : FCC Part15 Subpart C 2017, Section 15.247

Test Method(s) : ANSI C63.10: 2013

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test:	rotek anbor		May 05~15, 2018		
botek Anboten		Anbotek 2 mg	Andrek Diboten	Anbotek Anbotek	
Ambotek Ambote	NBOTE:	Win	nkey Wang	botek Anbotek	
Prepared by :	Anbotek	boten Anbu	ek Anbotek An	pore And	tek
	Allouden	(Teste	ed Engineer / Winkey Wa	ang)	
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Reviewer:		(Pro	ject Manager / Tangcy.	T) <sup>bote</sup> And	
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		Anbotek Anbotek	Joseph Alex	Anbotek Anbotek	
			low Che	n Anbotek	
Approved & Authorized S	Signer :	otek Anbote	k -potek Ant	100	49
	And botek	Anbotek Anbot	(Manager / Tom Chen)	Anboten Anbo	



# 1. General Information

# 1.1. Client Information

Applicant	:	Wintop Electronics Co., Limited
Address	:	Unit 04 7/F, Bright Way Tower 33, Mong Kok RD, KL, Hong Kong
Manufacturer	:	Shenzhen Wintop Electronics Co.,Ltd
Address	:	2, 3, 4/F, Building 46, Xinhe Road, Shangmugu, Pinghu Town, Longgang District, Shenzhen, China

## 1.2. Description of Device (EUT)

Product Name	: Bluetoo	th Earphone	
Model No.	: BT-583	ore And	ek Anbotek Anbotek Anbotek Anbotek
Trade Mark	: N/A	upore Vek Vi	potek Anbotek Anbo tek Anbotek Anbot
Test Power Supply	•	V, 60Hz for adapte V, Battery inside	er/AC 240V, 60Hz for adapter
	Operation	on Frequency:	2402MHz~2480MHz
	Transfer	Rate:	1/2/3 Mbits/s
Product	Number	of Channel:	79 Channels
Description	Modulat	tion Type:	GFSK, π/4-DQPSK, 8-DPSK
	Antenna	Type:	PCB Antenna
	Antenna	Gain(Peak):	Anbot O dBi hotek Anbotek Anbo

**Remark:** 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

## 1.3. Auxiliary Equipment Used During Test

100	111	A STATE OF THE STA
Adapter	:	Manufacturer: ZTE
		M/N: STC-A2050I1000USBA-C
		S/N: 201202102100876
		Input: 100-240V~50/60Hz 0.3A
		Output: DC 5V, 1000mA

## 1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

P	retest Mode	Description						
hotek	Mode 1	otek	Anbotek	Aupo	CH00	Anbotek	Anbote.	Ann
Anbotek	Mode 2	nbotek	Anbotek	Aup.	CH39	Anbotek	Anboro	F
Anbotel	Mode 3	nbotel	Anbote	-V.	CH78	Anbotel	Anbote	*eK
Anbe	Mode 4	r. Vupc	stek Ank	eeping T	X+ Char	ging Mode	stek Anbr	_+e

For Conducted Emission								
Final Test Mode	Description							
Mode 4	Keeping TX+ Charging Mode							

For Radiated Emission								
Final Test Mode	Description							
Mode 1	CH00 And Chock							
Mode 2	CH39							
Mode 3	CH78							
Mode 4	Keeping TX+ Charging Mode							

#### Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
  - (2) The data rate was set in 3Mbps for radiated emission due to the highest RF output power.



# 1.5. List of channels

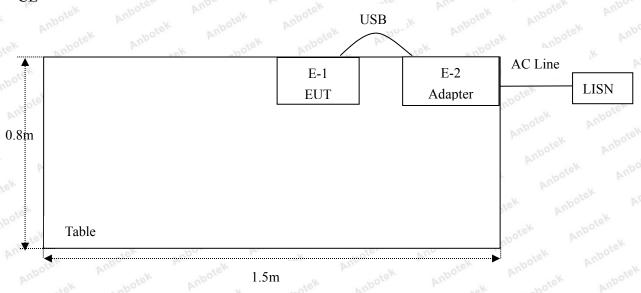
Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)
00	2402	An 17	2419	34	2436	51	2453	68	2470
01	2403	18	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53 oten	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21	2423	38	2440	55	2457	72	2474
05	2407	22	2424	39	2441	56	2458	73	2475
05	2408	23	2425	40	2442	57	2459	74	2476
16 N N	2409	24	2426	41 Anb	2443	58	2460	75	2477
08	2410	25	2427	42 N	2444	59	2461	76	2478
09	2411	26	2428	43	2445	60	2462	ote <sup>X</sup> 77	2479
An <sup>0</sup> 10	2412	27 📉	2429	44	2446	61 mb°	2463	78	2480
phPoto.	2413	28	2430	45	2447	62	2464		30010
12,000	2414	29	2431	46	2448	63	2465		
13	2415	30	2432	47,000	2449	64	2466		
14	2416	31	2433	48	2450	65	2467		100
15 15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67	2469		

## Note:

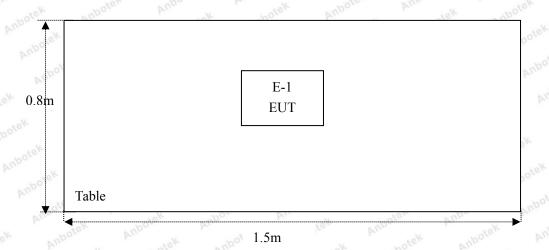
- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
- 2. EUT built-in battery-powered, fully-charged battery use of the test battery.

## 1.6. Description Of Test Setup

CEo



RE





# 1.7. Test Equipment List

Item	Equipment	Equipment Manufacturer		Serial No.	Last Cal.	Cal.	
	100		Model No.	WO.	y 0.V	Interva	
iek 1. jbotek	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year	
2.00	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year	
3. An	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year	
4.	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 17, 2017	1 Year	
5.	Spectrum Analysis	Agilent	N9038A	MY53227295	Nov. 17, 2017	1 Year	
6.	Preamplifier	SKET Electronic	BK1G18G30 D	KD17503	Nov. 17, 2017	1 Year	
7.,,,,	EMI Test Receiver	Rohde & Schwarz	ESPI	101604	Nov. 17, 2017	1 Year	
8.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2017	1 Year	
9.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year	
10.	Loop Antenna	Schwarzbeck	HFH2-Z2	100047	Nov. 17, 2017	1 Year	
11.,,,	Horn Antenna	Schewarzbeck	BBHA9170	9170-375	Nov. 17, 2017	1 Year	
12.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year	
13.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A	
14.	RF Test Control System	YIHENG	YH3000	2017430	Nov. 18, 2017	1 Year	
15.	Power Sensor	DAER	RPR3006W	15I00041SN045	Nov. 17, 2017	1 Year	
16.	Power Sensor	DAER	RPR3006W	15I00041SN046	Nov. 17, 2017	1 Year	
17.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year	
18.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Nov. 18, 2017	1 Year	
19.	Signal Generator	Agilent	E4421B	MY41000743	Nov. 18, 2017	1 Year	
20.	DC Power Supply	LW	TPR-6410D	349315	Nov. 01, 2017	1 Year	
21.	Constant Temperature Humidity Chamber	Sertep	ZJ-HWHS80 B	ZJ-17042804	Nov. 01, 2017	1 Year	

## 1.8. Measurement Uncertainty

Radiation Uncertainty	:	Ur = 3.9 dB (Horizontal)	Aup otek	mbotek Ar	por Am
		Ur = 3.8 dB (Vertical)	Andwork	Anbotek	Anboro An
3		Anbotek Anbote	K And hotek	Anbotek	Aupor
Conduction Uncertainty	:	Uc = 3.4 dB	And And botel	Anbotek	Anbo

## 1.9. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

#### FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

#### ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

#### **Test Location**

All Emissions tests were performed at

Shenzhen Anbotek Compliance Laboratory Limited.

at 1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102

## rek apolen

# 2. Summary of Test Results

Standard Section	Test Item	Result
15.203/15.247(c)	Antenna Requirement	PASS
15.207	Conducted Emission	PASS
15.205/15.209	Spurious Emission	PASS
15.247(b)(1)	Conducted Peak Output Power	PASS
15.247(a)(1)	20dB Occupied Bandwidth	PASS
15.247(a)(1)	Carrier Frequencies Separation	PASS
15.247(a)(1)	Hopping Channel Number	PASS
15.247(a)(1)	Dwell Time	PASS
15.247(d)	Band Edge	PASS

# 3. Conducted Emission Test

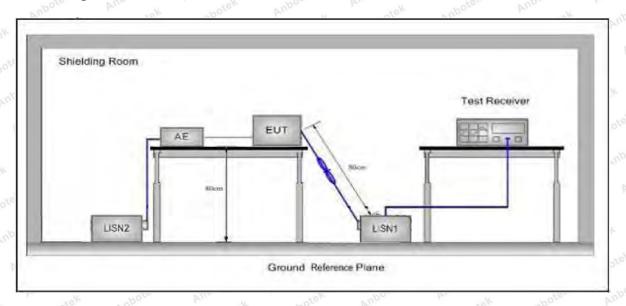
## 3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.2	07 Anborrak	Anboten Anbo stek					
	Emagnamary	Maximum RF	Maximum RF Line Voltage (dBuV)					
	Frequency	Quasi-peak Level	Average Level					
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *					
	500kHz~5MHz	Anbotek 56 box	46					
	5MHz~30MHz	60	50 house					

Remark: (1) \*Decreasing linearly with logarithm of the frequency.

(2) The lower limit shall apply at the transition frequency.

## 3.2. Test Setup



## 3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

### 3.4. Test Data

Please to see the following pages



9

10

11

12

1.8780

2.9020

2.9180

3.9340

-2.91

13.24

-2.93

-3.02

20.14

20.16

20.16

20.18

17.23

33.40

17.23

17.16

46.00

56.00

46.00

46.00

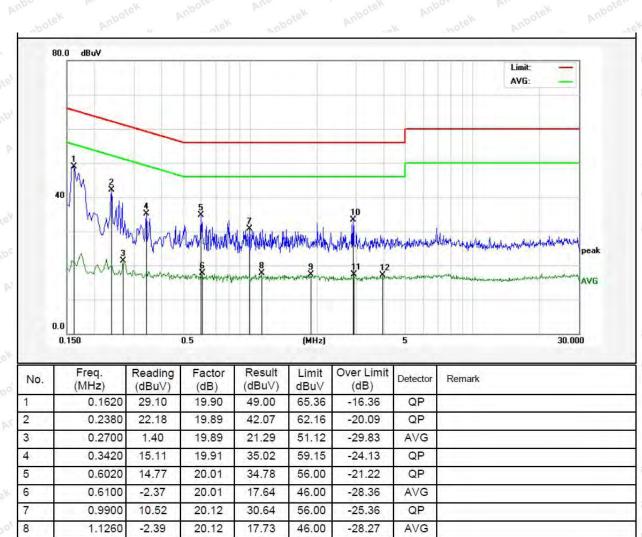
#### **Conducted Emission Test Data**

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Live Line

Tem.:22.5℃ Hum.:59%



-28.77

-22.60

-28.77

-28.84

AVG

QP

AVG

AVG

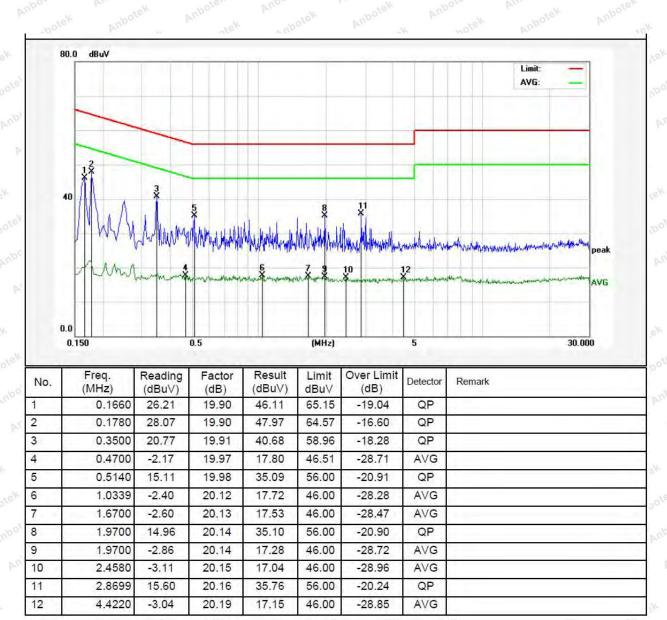
# **Conducted Emission Test Data**

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Neutral Line

Tem.:22.5°C Hum.:59%





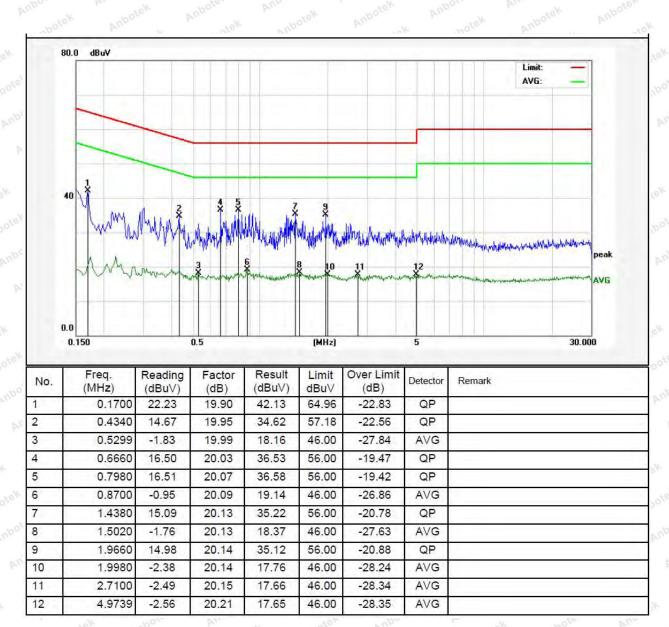
#### **Conducted Emission Test Data**

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line

Tem.:22.5°C Hum.:59%





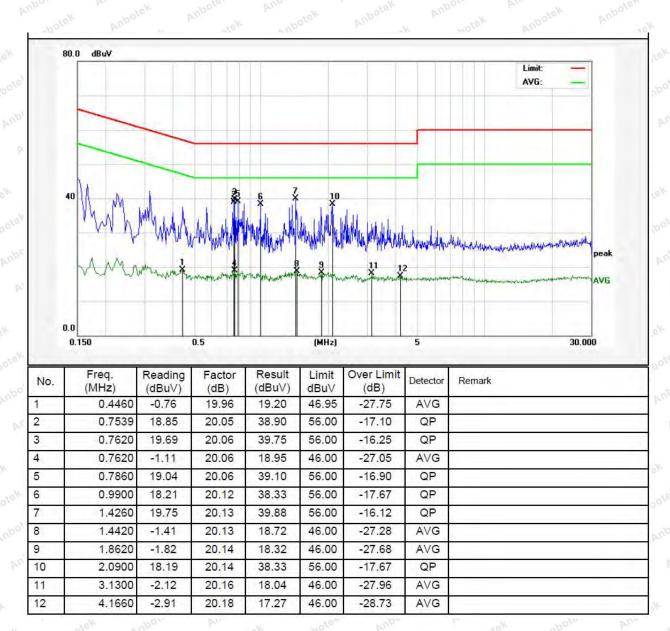
#### **Conducted Emission Test Data**

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line

Tem.:22.5°C Hum.:59%





# 4. Radiation Spurious Emission and Band Edge

## 4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.2	09 and 15.205	Ann	Anbotek	Anbo tek
	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz~0.490MHz	2400/F(kHz)	hotek - Anbo	co - Aun	300
	0.490MHz-1.705MHz	24000/F(kHz)	knbotek Ar	Pose Vin	notek 30 Anbo
	1.705MHz-30MHz	30	Anbatek	Anbore -	30
Test Limit	30MHz~88MHz	100	40.0	Quasi-peak	All 3lek
	88MHz~216MHz	150	43.5	Quasi-peak	3 Botek
	216MHz~960MHz	200	46.0	Quasi-peak	lek 3 nbotek
	960MHz~1000MHz	500	54.0	Quasi-peak	tek 3 nbo
	Al 1000MII	500	54.0	Average	Model 3
	Above 1000MHz	botek - Anbote	74.0	Peak	Anbo 3ek

#### Remark:

- (1)The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

## 4.2. Test Setup

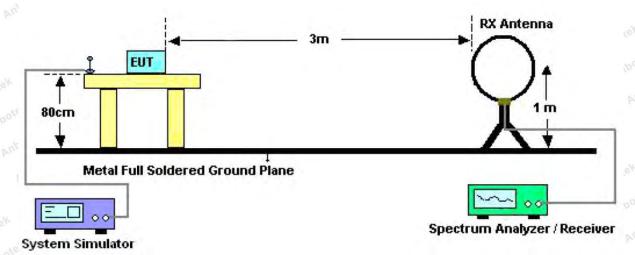


Figure 1. Below 30MHz



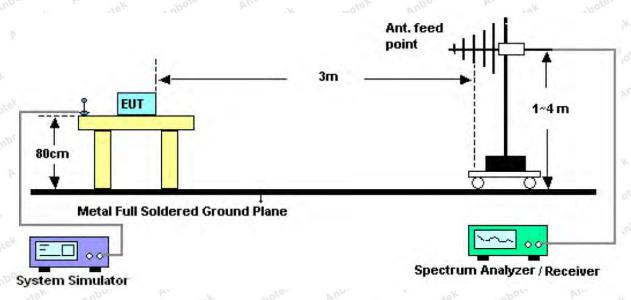


Figure 2. 30MHz to 1GHz

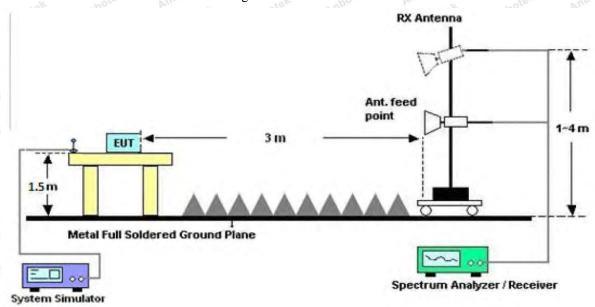


Figure 3. Above 1 GHz

#### 4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9\*6\*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying

aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW = 300kHz, Detector = Quasi-Peak, Trace mode = Max hold, Sweep- auto couple.

For above 1GHz,Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

#### 4.4. Test Data

#### **PASS**

During the test, pre-scan the GFSK,  $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation Middle channel which is the worst case, only the worst case is recorded in the report

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

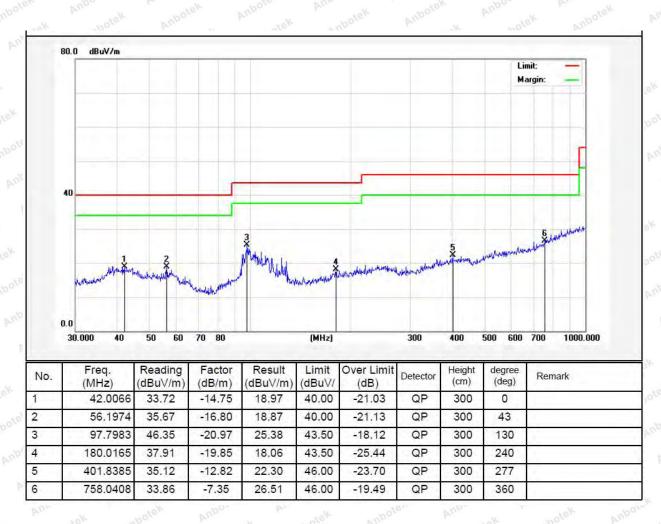


## Test Results (30~1000MHz)

Job No.: SZAWW180504013-01 Temp.(°C)/Hum.(%RH): 23.2°C/54%RH

Standard: FCC PART 15C Power Source: DC 3.7V, Battery inside

Test Mode: Mode 2 Polarization: Horizontal



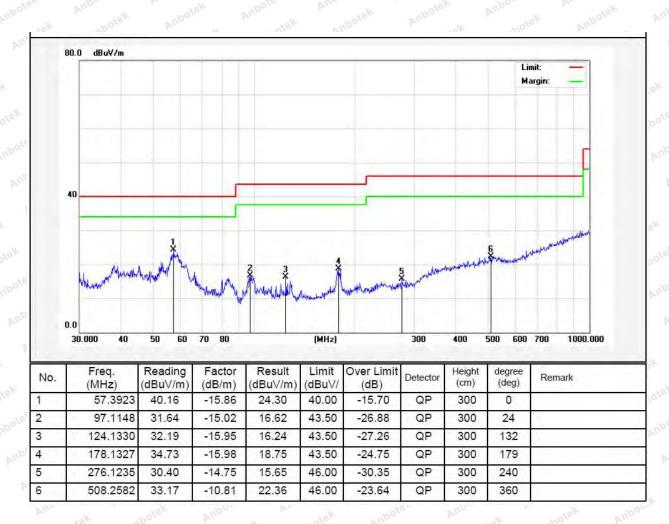


#### Test Results (30~1000MHz)

Job No.: SZAWW180504013-01 Temp.(°C)/Hum.(%RH): 23.2°C/54%RH

Standard: FCC PART 15C Power Source: DC 3.7V, Battery inside

Test Mode: Mode 2 Polarization: Vertical





## **Test Results (1GHz-25GHz)**

Test Mode: C	CH00			Test	channel: Lowe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	38.92	34.04	6.58	34.09	45.45	74.00	-28.55	Votod
7206.00	32.90	37.11	7.73	34.50	43.24	74.00	-30.76	Vek
9608.00	32.42	39.31	9.23	34.79	46.17	74.00	-27.83	V
12010.00	*	tek	botek P	Wpole	An	74.00	Vupo.	V
14412.00	* And	riek	nbotek	Aupore	Au, Potek	74.00	Anbos	v V
4804.00	43.54	34.04	6.58	34.09	50.07	74.00	-23.93	Н
7206.00	34.80	37.11	7.73	34.50	45.14	74.00	-28.86	H
9608.00	32.00	39.31	9.23	34.79	45.75	74.00	-28.25	Anbote H
12010.00	*nbote!	Aupo	* GK	obotek	Aupole	74.00	anbotek	PH
14412.00	ek * Anbo	Yek Ar	loor b	Sporek	Anboten	74.00	Anbotek	HAM
		**	A	verage Valu	ie			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	27.43	34.04	6.58	34.09	33.96	54.00	-20.04	V
7206.00	21.41	37.11	7.73	34.50	31.75	54.00	-22.25	V
9608.00	20.38	39.31	9.23	34.79	34.13	54.00	-19.87	V
12010.00	ootek * Ar	Por	anbotek	Anboles	Ambo	54.00	Anbo	V
14412.00	Anbotek	Anbore	An botek	Anboli	Amb	54.00	rek An	V
4804.00	31.84	34.04	6.58	34.09	38.37	54.00	-15.63	Aupole,
7206.00	23.69	37.11	7.73	34.50	34.03	54.00	-19.97	μĤ
9608.00	20.25	39.31	9.23	34.79	34.00	54.00	-20.00	Ηνb
12010.00	stek *	potek	Aupore.	Andotek	Anbotek	54.00	All	Н р
14412.00	*	abotek	Aupore	Pun.	k knbote	54.00	ok h	ote <sup>K</sup> H



## **Test Results (1GHz-25GHz)**

Test Mode: 0	CH39			Test	channel: Midd	le		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	36.91	34.38	6.69	34.09	43.89	74.00	-30.11	boteV
7323.00	31.57	37.22	7.78	34.53	42.04	74.00	-31.96	anbVel
9764.00	31.24	39.46	9.35	34.80	45.25	74.00	-28.75	V
12205.00	*	tek .	botek P	upote	Ar. botek	74.00	Anbo	V
14646.00	* And	stek	nbotek	Aupoten	Ann	74.00	Aupor	V
4882.00	41.12	34.38	6.69	34.09	48.10	74.00	-25.90	Н
7323.00	33.29	37.22	7.78	34.53	43.76	74.00	-30.24	H <sup>W</sup>
9764.00	30.62	39.46	9.35	34.80	44.63	74.00	-29.37	Anbore H
12205.00	*nbote <sup>k</sup>	Aupo	* GK	botek	Anboten	74.00	anbotek	PH
14646.00	lek * Anbo	rek br	Por b	abotek	Anbotek	74.00	Anbotek	ΗÞ
		**	A	verage Valu	e	0,0		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	25.81	34.38	6.69	34.09	32.79	54.00	-21.21	V
7323.00	20.31	37.22	7.78	34.53	30.78	54.00	-23.22	V
9764.00	19.41	39.46	9.35	34.80	33.42	54.00	-20.58	V
12205.00	potek * Ar	por	photek	Anbotes	Ambo	54.00	Anbo	V
14646.00	Anbote*	Aupor	An hotek	Anbole	Ambo	54.00	cek An	V
4882.00	30.00	34.38	6.69	34.09	36.98	54.00	-17.02	Aupoter.
7323.00	22.46	37.22	7.78	34.53	32.93	54.00	-21.07	ÞΉ
9764.00	19.11	39.46	9.35	34.80	33.12	54.00	-20.88	Hari
12205.00	*	potek	Yupote.	And	Anbotek	54.00	All	Н
14646.00	*	botek	Anboten	Vu <sub>0</sub>	k abote	54.00	-K Pri	ote <sup>W</sup> H

## **Test Results (1GHz-25GHz)**

Test Mode: 0	CH78			Test	channel: Highe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	36.35	34.72	6.79	34.09	43.77	74.00	-30.23	boteV
7440.00	31.19	37.34	7.82	34.57	41.78	74.00	-32.22	Ne Ve
9920.00	30.90	39.62	9.46	34.81	45.17	74.00	-28.83	V
12400.00	***************************************	tek "	botek P	upote	Pur Potek	74.00	Aupo.	V
14880.00	* And	atek .	nbotek	Aupoten	Aur	74.00	Anbor	V V
4960.00	40.44	34.72	6.79	34.09	47.86	74.00	-26.14	H
7440.00	32.86	37.34	7.82	34.57	43.45	74.00	-30.55	H
9920.00	30.23	39.62	9.46	34.81	44.50	74.00	-29.50	Anbou
12400.00	*nbote!	Aupo	18K	abotek	Anbore	74.00	Aupotek	PĤ
14880.00	ek * Anbe	Yek Vi	loo. b	- abotek	Aupoten	74.00	Anbotek	ΗÞ
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	25.40	34.72	6.79	34.09	32.82	54.00	-21.18	V
7440.00	20.03	37.34	7.82	34.57	30.62	54.00	-23.38	V
9920.00	19.16	39.62	9.46	34.81	33.43	54.00	-20.57	V
12400.00	botek * Ar	lpo, rek	abotek.	Anbote	And	54.00	Anbo	V
14880.00	Anbote*	Anbor	A. botek	Anbore	Anba	54.00	rek An	V
4960.00	29.53	34.72	6.79	34.09	36.95	54.00	-17.05	Anbote.
7440.00	22.14	37.34	7.82	34.57	32.73	54.00	-21.27	μĤ
9920.00	18.82	39.62	9.46	34.81	33.09	54.00	-20.91	Ηo
12400.00	otek *	potek	Aupore	And	Anbotek	54.00	pa nbote	Н
14880.00	*	potek	Anbote	Ann	k abote	54.00	er br	ote <sup>K</sup> H

#### Remark

- 1. During the test, pre-scan the GFSK,  $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 3. "\*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.



# Radiated Band Edge:

Test Mode: 0	CH00		101	Test	t channel: Lowe	st	V.O.	
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	43.76	29.15	3.41	34.01	42.31	74.00	-31.69	Hek
2400.00	60.67	29.16	3.43	34.01	59.25	74.00	-14.75	H
2390.00	44.39	29.15	3.41	34.01	42.94	74.00	-31.06	V
2400.00	62.80	29.16	3.43	34.01	61.38	74.00	-12.62	V
			A	verage Valı	ie	100		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	34.11	29.15	3.41	34.01	32.66	54.00	-21.34	Hoots
2400.00	45.40	29.16	3.43	34.01	43.98	54.00	-10.02	HANY
2390.00	34.11	29.15	3.41	34.01	32.66	54.00	-21.34	v V
2400.00	47.13	29.16	3.43	34.01	45.71	54.00	-8.29	otelV

Test Mode: 0	CH78			Test	channel: High	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	45.96	29.28	3.53	34.03	44.74	74.00	-29.26	"PoH
2500.00	44.97	29.30	3.56	34.03	43.80	74.00	-30.20	Hote
2483.50	46.95	29.28	3.53	34.03	45.73	74.00	-28.27	V
2500.00	46.05	29.30	3.56	34.03	44.88	74.00	-29.12	V
			A	verage Valu	ie			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	36.94	29.28	3.53	34.03	35.72	54.00	-18.28	ATHO TO
2500.00	34.82	29.30	3.56	34.03	33.65	54.00	-20.35	Hnb
2483.50	38.23	29.28	3.53	34.03	37.01	54.00	-16.99	V
2500.00	34.82	29.30	3.56	34.03	33.65	54.00	-20.35	tek V

## Remark:

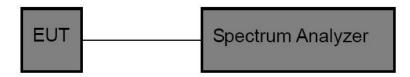
- 1. During the test, pre-scan the GFSK,  $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor

# 5. Maximum Peak Output Power Test

## 5.1. Test Standard and Limit

Test Standard	FCC Part15 C S	Section 15.247	(b)(3)	An	Anbotek	Anbo stek
Test Limit	125 mW	Anbotek	Anbors	All	Anbotek	Anboatek

## 5.2. Test Setup



#### 5.3. Test Procedure

- 1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
- 2. Spectrum Setting:

RBW > the 20 dB bandwidth of the emission being measured

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

VBW ≥ RBW

Sweep = auto

Detector function = peak

Trace = max hold

#### 5.4. Test Data

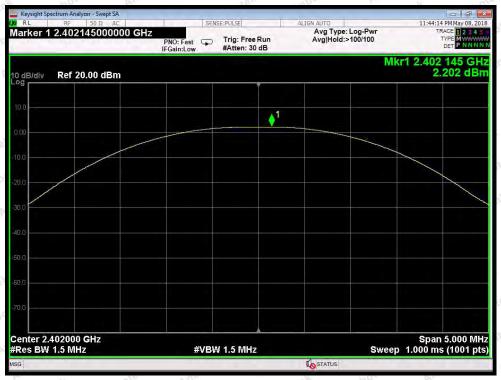
Test Item : Max. peak output power Test Mode : CH Low ~ CH High

Test Voltage : DC 3.7V, Battery inside Temperature :  $24^{\circ}$ C Test Result : PASS Humidity :  $55^{\circ}$ RH

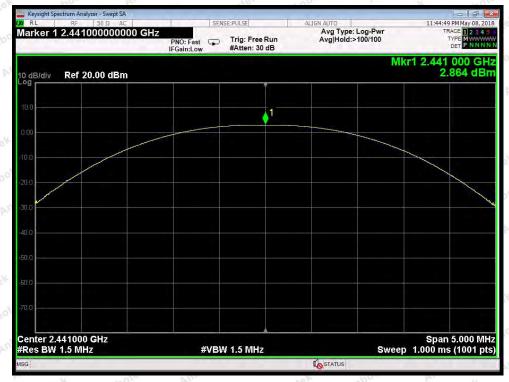
Channel Fr (MH	• •	Peak Power output (dBm)	Limit (dBm)	Results	Modulation
240	2	2.202	20.96	PASS	BDR
244	1	2.864	20.96	PASS	BDR
248	0	2.601	20.96	PASS	BDR
240	2,000	1.945	20.96	PASS	EDR
244	1 abotek	2.648	20.96	PASS	EDR
248	0 hotel	1.200 And	20.96	PASS	EDR NOOTE

Remark: The EDR was tested on  $(\pi/4DQPSK, 8DPSK)$  modes, only the worst data of (8DPSK) is attached in the following pages



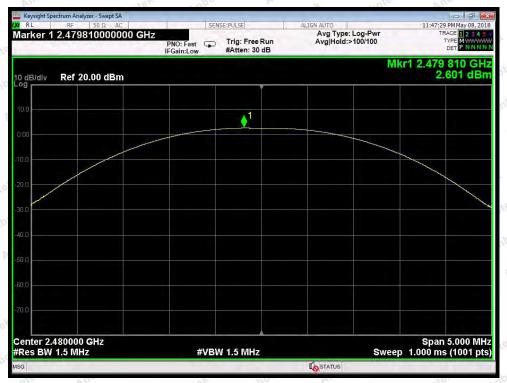


Test Mode: BDR---Low

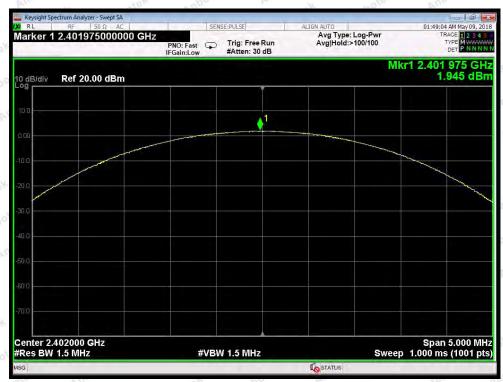


Test Mode: BDR---Middle



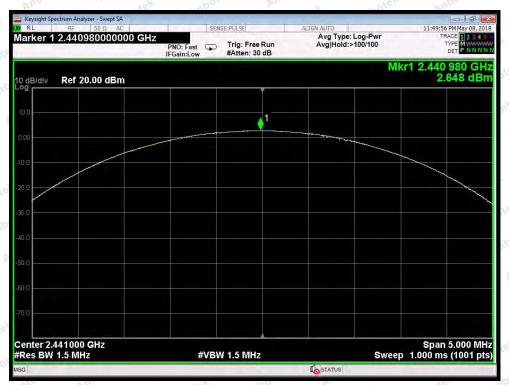


Test Mode: BDR---High

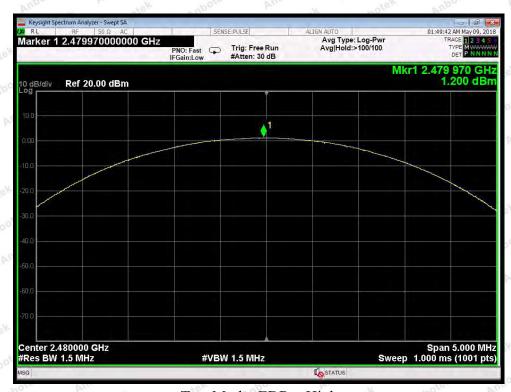


Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

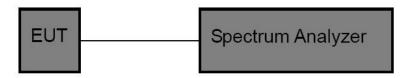


# 6. 20DB Occupy Bandwidth Test

## 6.1. Test Standard

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Ann	hotek	Anbo	p.
105t Standard	1 CC 1 ulti 3 C Section 13.2+7 (u)(1)				

## 6.2. Test Setup



## **6.3. Test Procedure**

Using the following spectrum analyzer settings:

- 1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

#### 6.4. Test Data

Test Item : 20dB BW Test Mode : CH Low ~ CH High

Test Voltage : DC 3.7V, Battery inside Temperature :  $24^{\circ}$ C Test Result : PASS Humidity :  $55^{\circ}$ RH

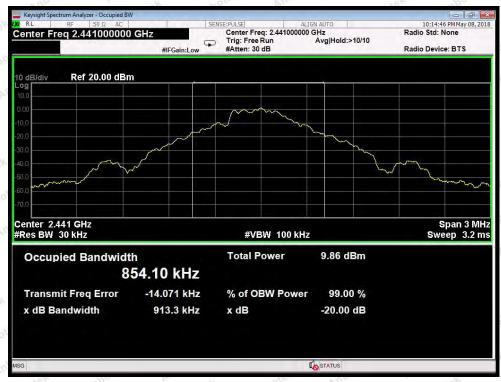
Channel	Frequency(MHz)	20dB Down BW(kHz)	Modulation Mode
Low	2402	928.3	BDR
Middle	2441	913.3	BDR
High	2480	878.7	BDR
Low	2402	1225.0	EDR
Middle	2441	1225.0	EDR
High	2480	1243.0	EDR

Remark: The EDR was tested on  $(\pi/4DQPSK, 8DPSK)$  modes, only the worst data of (8DPSK) is attached in the following pages.



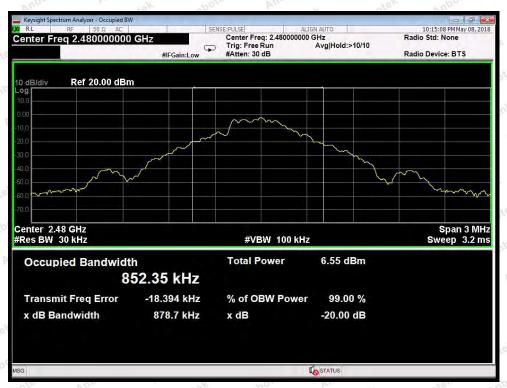


Test Mode: BDR---Low

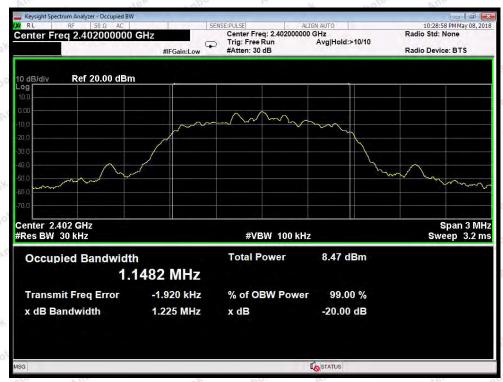


Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High



# 7. Carrier Frequency Separation Test

## 7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Anbotek	Anbo stek
Test Limit	>25KHz or >two-thirds of the 20 dB bandwidth	Anbotek	Anbo

## 7.2. Test Setup



#### 7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

- 1. Span= Wide enough to capture the peaks of two adjacent channels
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

## 7.4. Test Data

Test Item : Frequency Separation Test Mode :  $CH Low \sim CH High$ Test Voltage : DC 3.7V, Battery inside Temperature :  $24^{\circ}C$ 

Test Result : PASS Humidity : 55%RH

Channel	Frequency	Separation Read	Limit	Modulation
	(MHz)	Value (kHz)	(kHz)	Mode
Low	2402	1000	928.3	BDR
Middle	2441	1000	913.3	BDR
High	2480	1000	878.7	BDR
Low Andrew	2402	1000	816.7	EDR
Middle	2441	1000	816.7	EDR
High	2480	1000	826.7	EDR

#### Remark:

- 1. The limit of mode (EDR) is 2/3 of 20dB BW;
- 2. The EDR was tested on ( $\pi$ /4DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.





Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



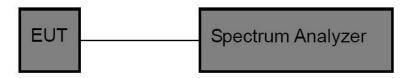
Test Mode: EDR---High

# 8. Number of Hopping Channel Test

#### 8.1. Test Standard and Limit

Test Standard	FCC Part15 C	Section 15.2	47 (a)(1)	Anhotek	Anbotek	Anbo	p.
Test Limit	>15 channels	Anbotek	Anboro	An	Anbotek	Anbo	

### 8.2. Test Setup



#### 8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

- 1. Span= the frequency band of operation
- 2. Set the RBW = 100kHz.
- 3. Set the VBW = 300kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

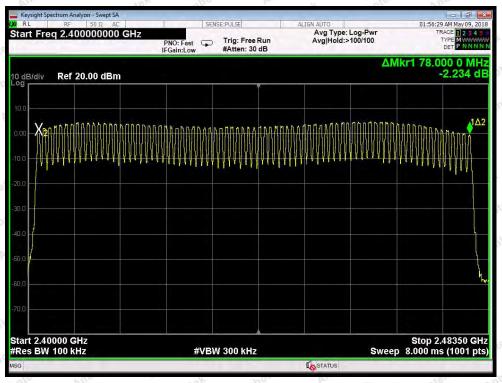
#### 8.4. Test Data

Test Item : Number of Hopping Frequency Test Mode : CH Low ~ CH High

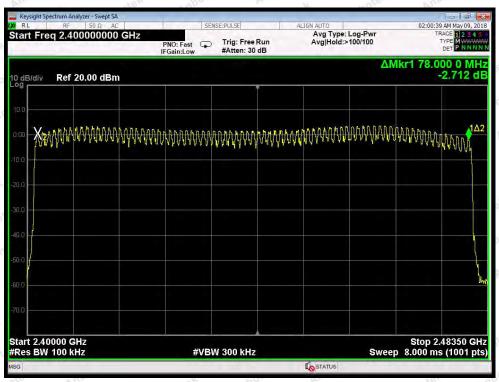
Test Voltage : DC 3.7V, Battery inside Temperature :  $24^{\circ}$ C Test Result : PASS Humidity :  $55^{\circ}$ RH

Hopping Channel Frequency		Quantity of Hopping Channel	Quantity of Hopping Channel		
8	Range				
101	2402-2480MHz	79 Tel	>15		





BDR Mode



EDR Mode

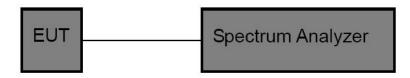


### 9. Dwell Time Test

#### 9.1. Test Standard and Limit

Test Standard	FCC Part15 (	C Section 15.2	47 (a)(1)	Andhotek	Anbotek	Anbo. stek	
Test Limit	0.4 sec	Anbotek	Anboro	An	Anbotek	Anbo	P

### 9.2. Test Setup



#### 9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

- 1. Span= zero span, centered on a hopping channel
- 2. Set the RBW = 1 MHz.
- 3. Set the VBW = 1 MHz.
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

#### 9.4. Test Data

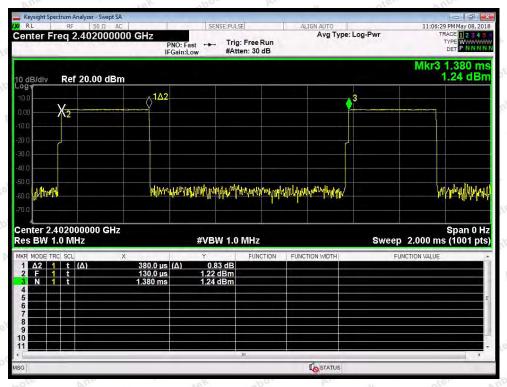
Test Item : Time of Occupancy Test Mode : CH Low ~ CH High

Test Voltage : DC 3.7V, Battery inside Temperature :  $24^{\circ}$ C Test Result : PASS Humidity :  $55^{\circ}$ RH

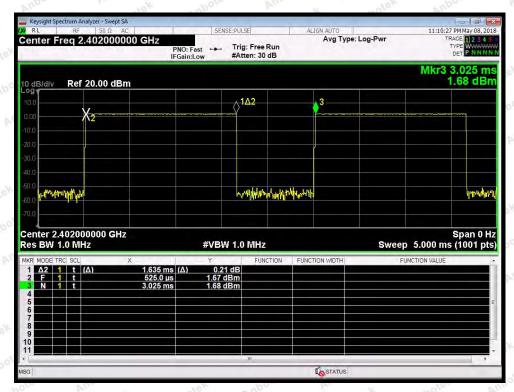
	V 0	The state of the s			10.
Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)	Modulation
DH1	0.380	time slot length *1600/2 /79 * 31.6	121.60	0.4	BDR
DH3	1.635	time slot length *1600/4 /79 * 31.6	261.60	0.4	BDR
DH5	2.880	time slot length *1600/6 /79 * 31.6	307.20	0.4	otek BDR Anbo
3DH1	0.386	time slot length *1600/2 /79 * 31.6	123.52	0.4	EDR
3DH3	1.630	time slot length *1600/4 /79 * 31.6	260.80	0.4	EDR
3DH5	2.888	time slot length *1600/6 /79 * 31.6	308.05	0.4	EDR

Remark: The EDR was tested on ( $\pi$ /4DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.



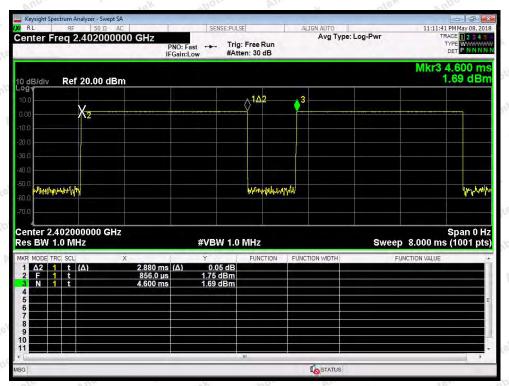


Test Mode: BDR---DH1

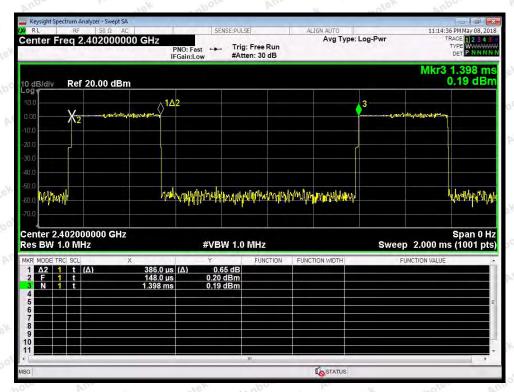


Test Mode: BDR---DH3



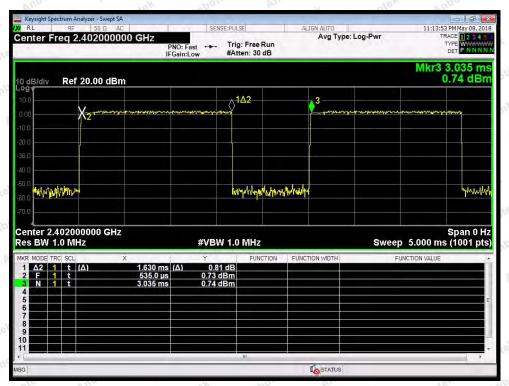


Test Mode: BDR—DH5

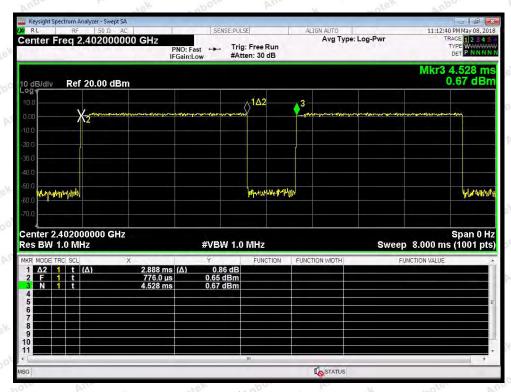


Test Mode: EDR---3DH1





Test Mode: EDR---3DH3



Test Mode: EDR—3DH5

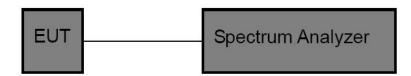


# 10. 100kHz Bandwidth of Frequency Band Edge Requirement

### 10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

#### 10.2. Test Setup



#### 10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

- 1. Set the RBW = 100kHz.
- 2. Set the VBW = 300kHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode =  $\max$  hold.
- 6. Allow trace to fully stabilize.

#### 10.4. Test Data

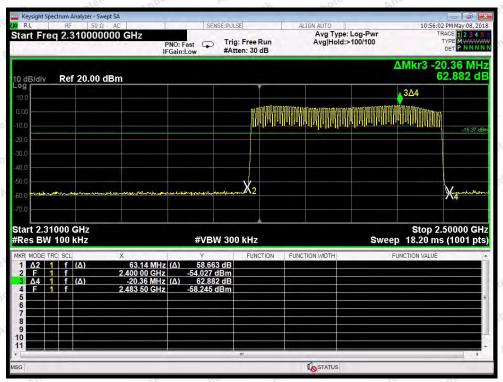
Test Item : Band edge : CH Low ~ CH High

Test Voltage : DC 3.7V, Battery inside Temperature :  $24^{\circ}$ C Test Result : PASS Humidity :  $55^{\circ}$ RH

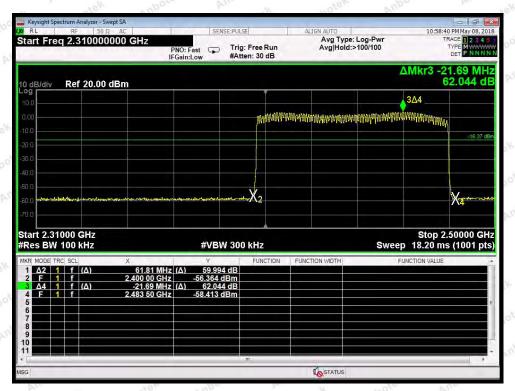
Remark: The EDR was tested on ( $\pi$ /4DQPSK, 8DPSK) modes, only the worst data of ( $\pi$ /4DQPSK) is attached in the following pages.



#### For Hopping Mode



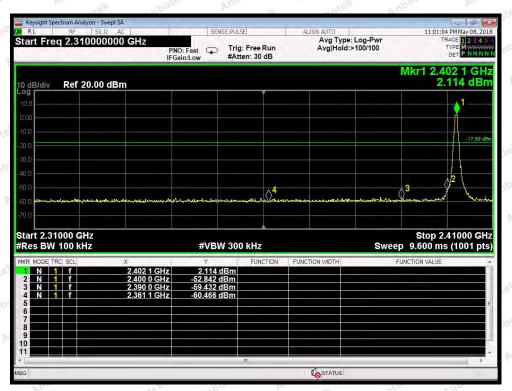
BDR mode



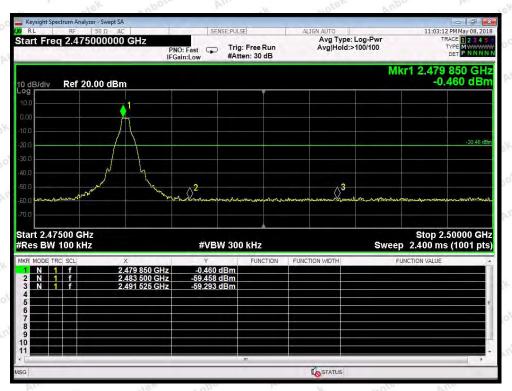
EDR mode



#### For Non-Hopping Mode



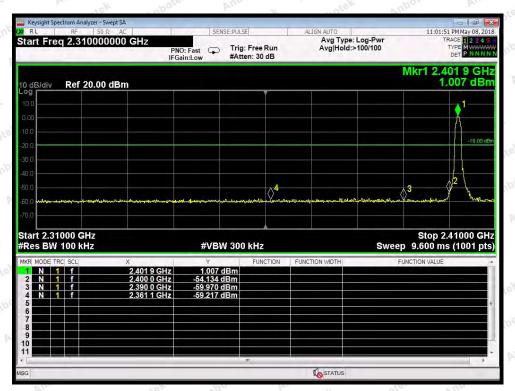
BDR mode -- Lowest



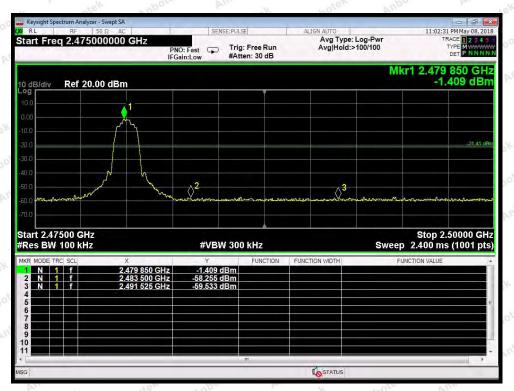
BDR mode -- Highest



#### For Non-Hopping Mode



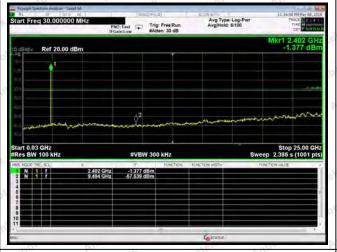
EDR mode -- Lowest

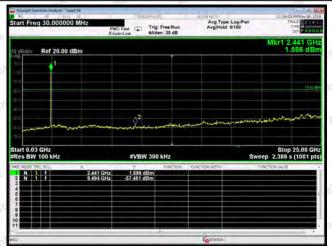


EDR mode -- Highest



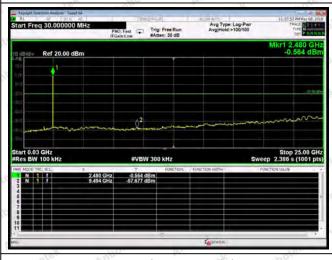
#### Conducted Emission Method

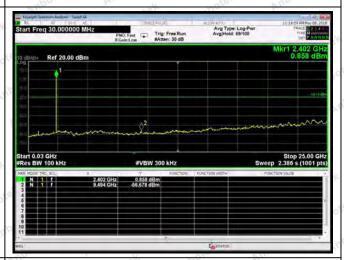




Test Mode: BDR---Low

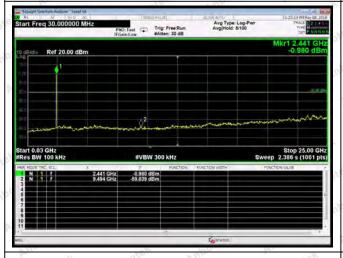






Test Mode: BDR---High

Test Mode: EDR---Low





Test Mode: EDR---Mid

Test Mode: EDR---High

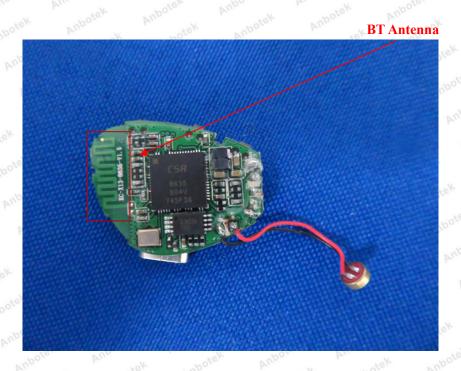
## 11. Antenna Requirement

### 11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
	1) 15.203 requirement:
	An intentional radiator shall be designed to ensure that no antenna other than that furnished
	by the responsible party shall be used with the device. The use of a permanently
	attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the
	manufacturer may design the unit so that a broken antenna can be replaced by the user, but
Requirement	the use of a standard antenna jack or electrical connector is prohibited.
	2) 15.247(c) (1)(i) requirement:
	Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed.
	Point-to-point operations may employ transmitting antennas with directional gain greater
	than 6dBi provided the maximum conducted output power of the intentional radiator is
	reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

#### 11.2. Antenna Connected Construction

The bluetooth antenna is PCB Antenna which permanently attached, and the best case gain of the antenna is 0 dBi. It complies with the standard requirement.

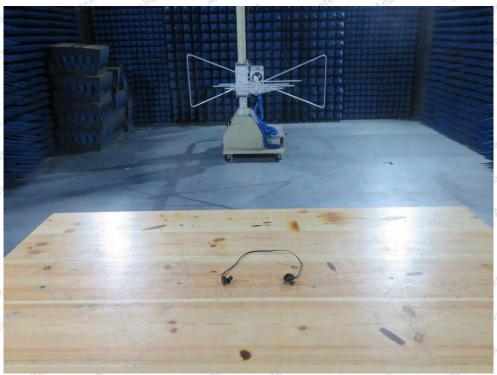


# APPENDIX I -- TEST SETUP PHOTOGRAPH

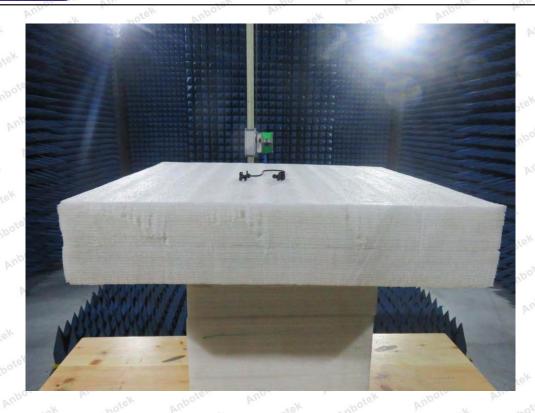




Photo of Radiation Emission Test







## APPENDIX II -- EXTERNAL PHOTOGRAPH









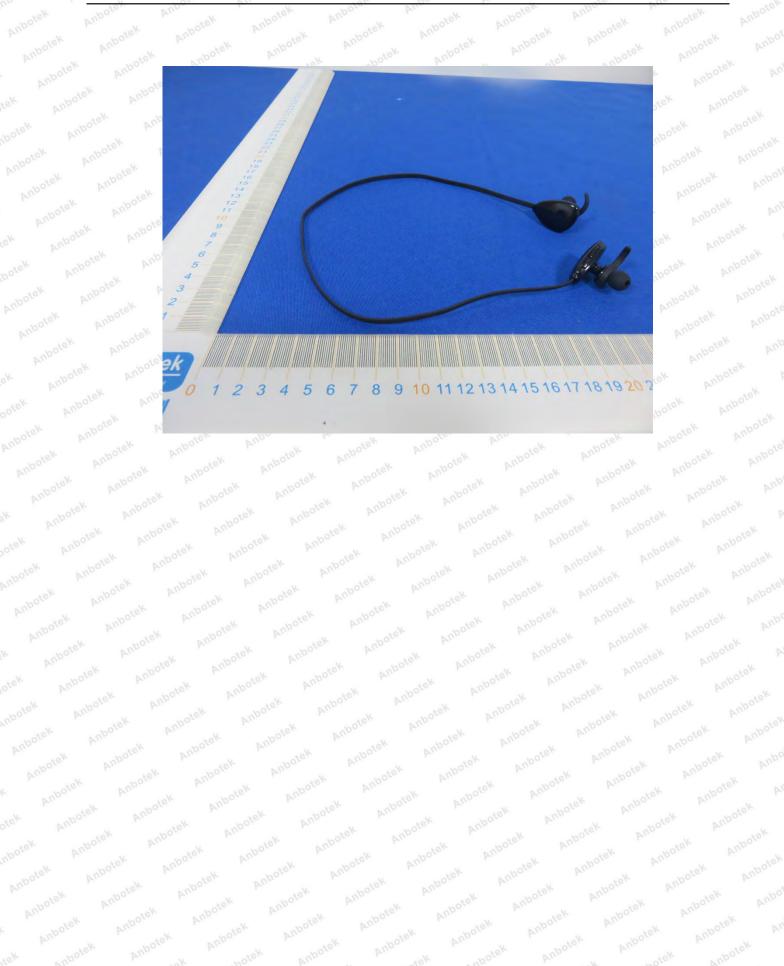








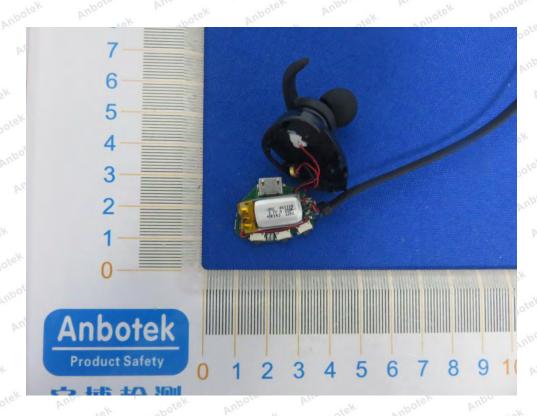




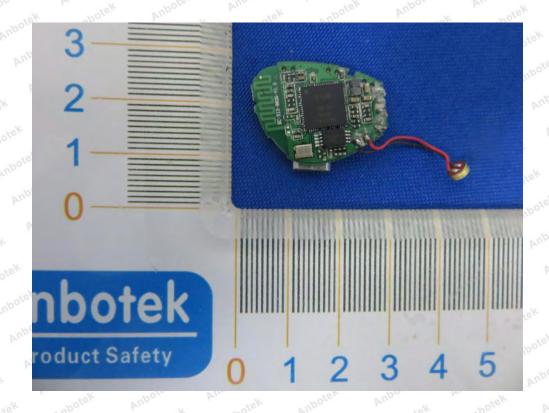


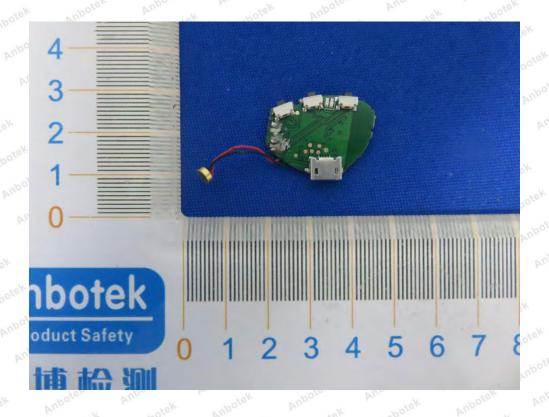
## APPENDIX III -- INTERNAL PHOTOGRAPH



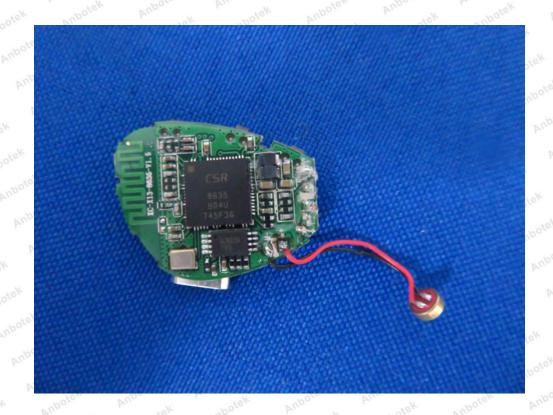


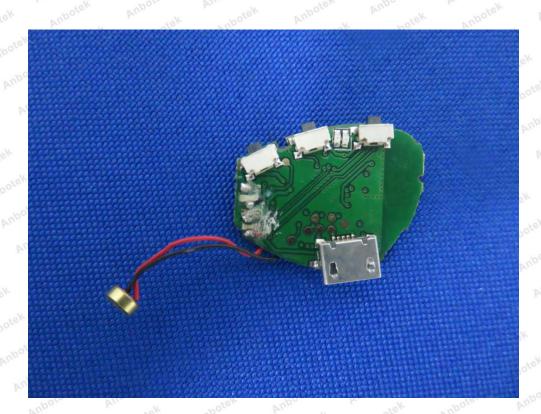


















End of Report